

MiniProfiler-C

Miniatuized Pickup

breitmeier
A NanoFocus Company

nanofocus®
see more

Portable Miniature Roughness & Waviness Measurement Device

- Roughness + Waviness**
 $100 \mu\text{m} - 2 \text{ mm}$
- Adaptable**
Usable on various workpiece shapes
- Versatile**
Wide variety of measurement tasks
- Built-in camera**
- Easily attachable**
- Stylus protection**
- Quick-change stylus**
- Vibration resistant**
- USB / WiFi / Bluetooth**



The MiniProfiler-C is a **tactile skidless measurement device with an integrated camera**. It captures simultaneous imaging of the surface during the measurement.

It belongs to the MiniProfiler product line of Breitmeier Messtechnik GmbH. Since 2001 the company has been designing, developing and building cutting-edge measurement devices and systems in Germany.

Our MiniProfiler product line is available for a **wide range of applications** which require measurement of technical surfaces, such as shafts, grooves on shafts and pistons, camshafts, vent sealing lips, cylinder bores and metalsheet.

for Quality Assurance in Laboratories & on Production Lines



MiniProfiler-C



MiniProfilers

MiniProfiler-C
with camera

Technical Specification

ISO 3274	Measurement system with reference datum	
Measurement principle	Skidless stylus; tactile	
Reference datum	Precision flat	
Measurement uncertainty	[%]	0.5
Measurement range	[µm]	100; 500; 1000; 2000;
Resolution	[Bit]	20
Stylus tip radius	[µm]	2; 5; *
Stylus angle	[°]	90; 60; *
Measuring distance	[mm]	15; *
Travel speed	[mm/s]	0.1 - 2
Stylus protection	Lift off actuator	
Internal memory	Pickup and service data; measurement programs	
Quick-change components	Stylus; cable	
Camera field of view	[mm ²]	Approx. 3.3 megapixel; *

Standards

ISO	ISO 4287; ISO 13565-2; *
Other standards	Daimler MBN 31007; SEP 1941; JIS B 0610; *
Profile parameters	Pt; Pc; Pv; Py; Pa; Pp; Pmr; *
Waviness parameters	Wt; Wc; Wv; Wy; Wa; Wp; Wsa(1-5); Wa0.8; Wca; *
Roughness parameters	Rt; Rv; Ry; Ra; Rmr; Rp; Rq; Rz; Rmax; dominant waviness; *
Core roughness parameters	Rk; Rpk; Rpk*; Rvk; Rvk*; Mr1; Mr2; R3z; R3max; *
Filters	Gauss; ISO 1562/16610-21; ISO 13565-1; VDA 2008; ISO 16610-31; *

Software

Number of measurement programs	> 1000
Data interfaces	USB 2.0; USB 3.0; RS 232; QDAS; Excel; PDF (configurable); *

Measurement Environment and Dimensions

Operating position	Arbitrary
Operating temperature	[°C]
Dimensions	[mm]
Weight	[g]

* Customizable



MiniProfiler MP50/75

MiniProfiler MP15
for CMM or robot